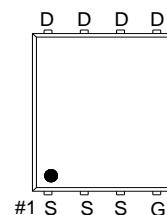
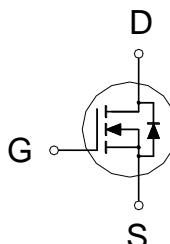


NIKO-SEM
**N-Channel Enhancement Mode
Field Effect Transistor**
PP1410AK
PDFN 5x6P
Halogen-Free & Lead-Free
PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
100V	14mΩ	49A

MSL (Moisture Sensitivity Level) 1.


G. GATE
D. DRAIN
S. SOURCE
**ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	49	A
	$T_C = 100^\circ\text{C}$		35	
Pulsed Drain Current ¹		I_{DM}	78	
Continuous Drain Current	$T_A = 25^\circ\text{C}$	I_D	9.6	
	$T_A = 70^\circ\text{C}$		8	
Avalanche Current		I_{AS}	12.7	
Avalanche Energy	$L = 1\text{mH}$	E_{AS}	80.6	mJ
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	78	W
	$T_C = 100^\circ\text{C}$		39	
Power Dissipation ³	$T_A = 25^\circ\text{C}$	P_D	3	
	$T_A = 70^\circ\text{C}$		2.1	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 175	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10\text{s}$	$R_{\theta JA}$	50	72	°C / W
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$			
Junction-to-Case	Steady-State	$R_{\theta JC}$			

¹Pulse width limited by maximum junction temperature.²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$.³The Power dissipation is based on $R_{\theta JA} t \leq 10\text{s}$ value.

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	100			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	2.4	3	4	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 100\text{V}, V_{\text{GS}} = 0\text{V}$			1	
		$V_{\text{DS}} = 100\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$			10	μA
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 10\text{V}, I_D = 20\text{A}$		10.5	14	$\text{m}\Omega$
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 4\text{A}$		16.8		S
DYNAMIC³						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 50\text{V}, f = 1\text{MHz}$		1488		pF
Output Capacitance	C_{oss}			269		
Reverse Transfer Capacitance	C_{rss}			10		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		0.6		Ω
Total Gate Charge ²	Q_g	$V_{\text{DS}} = 50\text{V}, V_{\text{GS}} = 10\text{V}, I_D = 20\text{A}$		25		nC
Gate-Source Charge ²	Q_{gs}			5.7		
Gate-Drain Charge ²	Q_{gd}			7.8		
Turn-On Delay Time ²	$t_{d(\text{on})}$	$V_{\text{DS}} = 50\text{V}, I_D \approx 20\text{A}, V_{\text{GS}} = 10\text{V}, R_{\text{GEN}} = 6\Omega$		13		nS
Rise Time ²	t_r			23		
Turn-Off Delay Time ²	$t_{d(\text{off})}$			26		
Fall Time ²	t_f			27		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS³ ($T_J = 25^\circ\text{C}$)						
Continuous Current	I_S				49	A
Forward Voltage ¹	V_{SD}	$I_F = 20\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		44		nS
Reverse Recovery Charge	Q_{rr}			51		nC

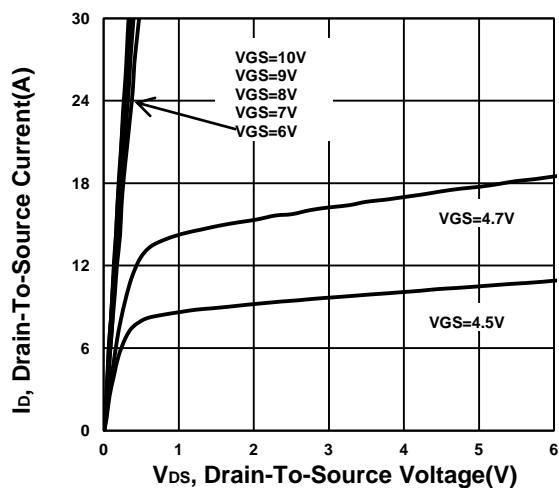
¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Guaranteed by design, not subject to production testing.

NIKO-SEM

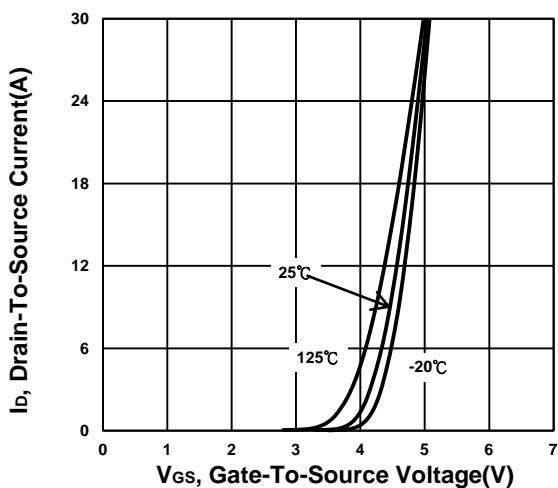
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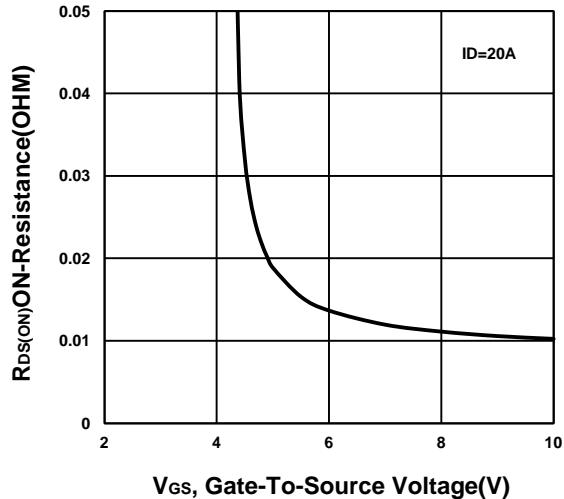
Output Characteristics



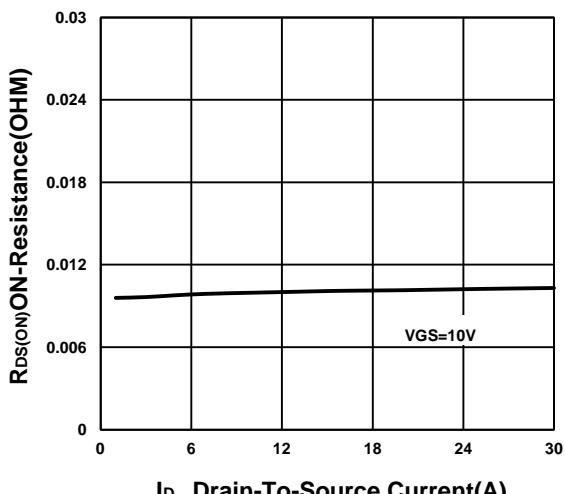
Transfer Characteristics



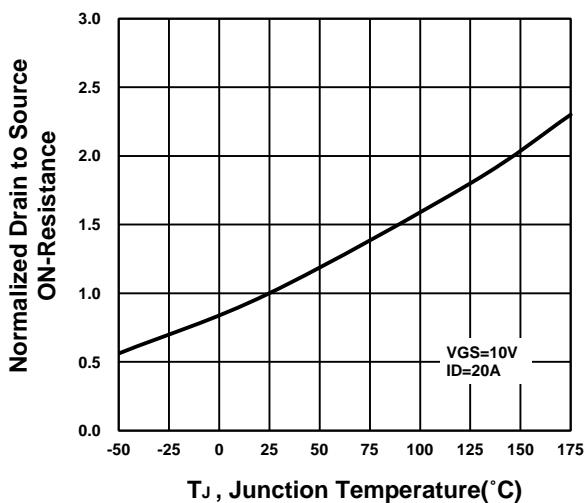
On-Resistance VS Gate-to-Source Voltage



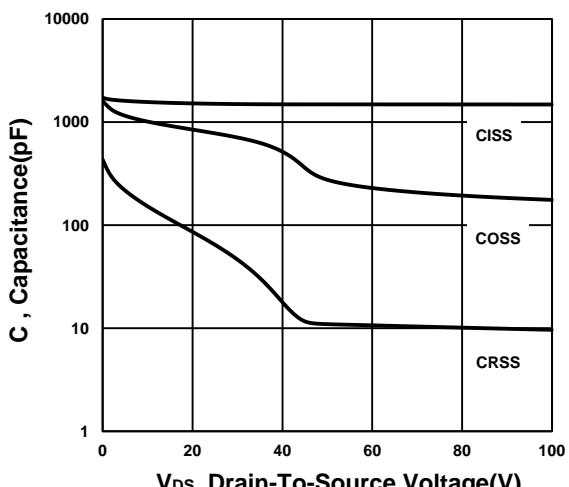
On-Resistance VS Drain Current



On-Resistance VS Temperature



Capacitance Characteristic

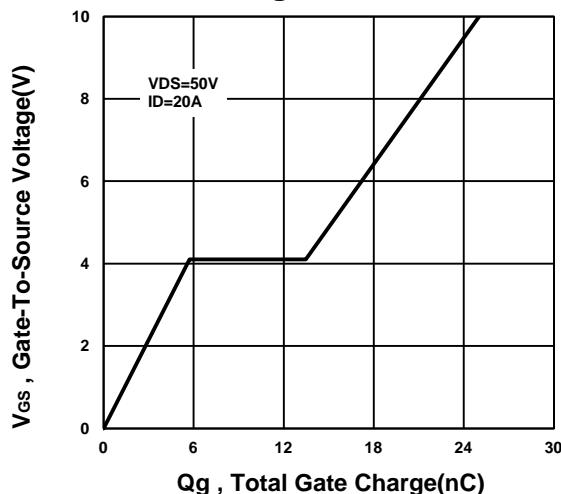


NIKO-SEM

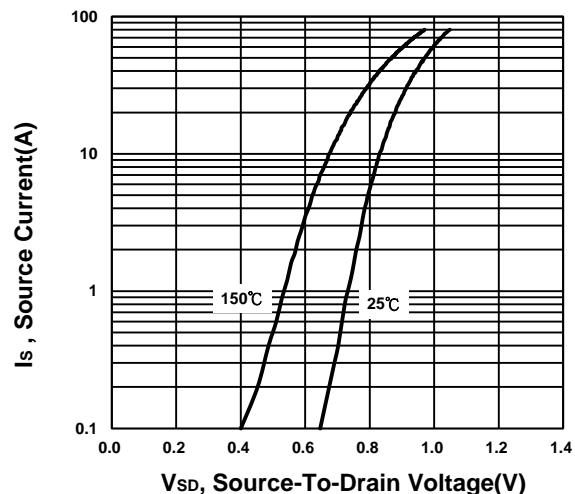
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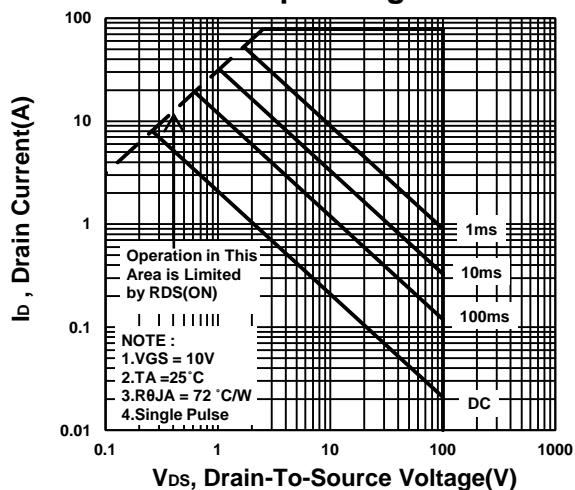
Gate charge Characteristics



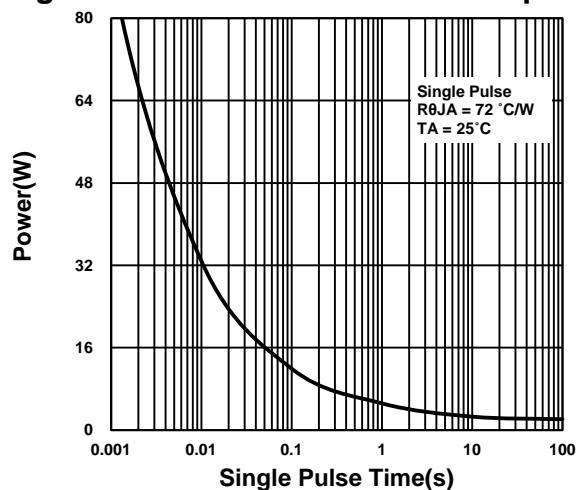
Source-Drain Diode Forward Voltage



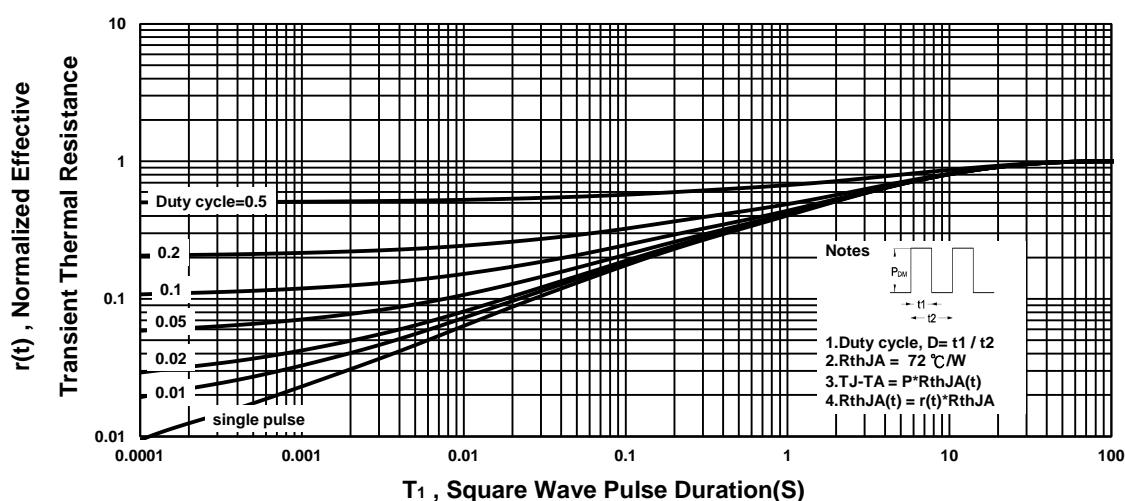
Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

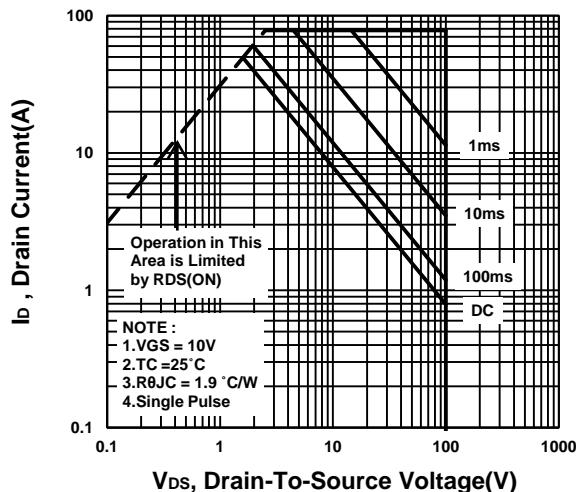


NIKO-SEM

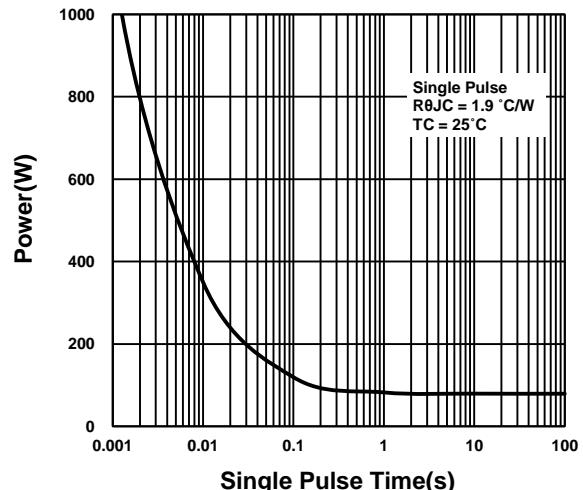
**N-Channel Enhancement Mode
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Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

